Form PTO-1449 (Modified)

In re:	ATTY. DOCKET NO. CU-3424	SERIAL NO. 10/701,306
INFORMATION DISCLOSURE STATEMENT BY APPLICANT	. APPLICANT Hea Suk Jung	
(37 CFR 1.98(b))	FILING DATE November 4, 2003	GROUP 2816

U.S. PATENT DOCUMENTS

EXAMI- NER INITIAL	•	PATENT NUMBER OR APP PAT PUB							ISSUE DATE	PATENTEE	CLASS	SUB- CLASS	FILING DATE D'APPROPRIATE
WH	-	6	5	2	5	9	8	8	02/2003	Ryu et al.	365	233	
hos		6	3	1	0	5	0	5	10/2001	Ogawa et al.	327	276	
lus		6	0	2	9	2	5	0	02/2000	Keeth	7/3	400	
und		6	0	1	1	7	3	2	01/2000	Harrison et al.	366	194	
wir		5	9	6	တ	5	5	1	10/1999	Fujioka	327	149	
إبهما		5	9	2	0	5	1	8	07/1999	Harrison et al.	365	233	
und	2003	0	0	0	1	6	3	7	01/2003	Jung	327	158	
wo	2002	0	0	9	7	0	7	4	07/2002	Kim et al.	327	158	
your	2002	0	0	7	5	0	4	7	06/2002	Tsukikawa	327	156	
كميها	2002	0	0	1	7	9	3	တ	02/2002	Okuda et al.	327	296	

FOREIGN PATENT OR PUBLISHED FOREIGN PATENT APPLICATION

EXAMIN ER INITIAL		D	oci	JME	ΝT	NUÑ	1BE	R	PUBLICATION DATE	COUNTRY OR PATENT OFFICE	CLASS	SUB- CLASS	TRANSLATION YES NO
m	2002		1	8	5	3	1	3	06/2002	Japan			XAbs
ind	2002		0	1	7	9	ζ3	9	02/2002	Japan			XAS
me	2002		3	1	4	4	0	7	07/2002	Japan			XAbs
LAN	11		0	2	7	1	1	6	01/1999	Japan			XAG
W	0004		2	0	9	4	1	5	08/2001	Japan			XAL

EXAMINER: Initial citation considered. Draw line through citation if not In conformance and not considered. Include copy of this form with next communication to applicant.

(Form PTO-1449)